

<b>Notice of References Cited</b>		Application/Control No. 10/662,022	Applicant(s)/Patent Under Reexamination EDELSTEIN ET AL.	
		Examiner Olivia T. Luk	Art Unit 2812	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,713,390	03-2004	M'Saad et al.	438/680
	B	US-6,806,207	10-2004	Huang et al.	438/758
	C	US-6,072,227	06-2000	Yau et al.	257/642
	D	US-6,570,256	05-2003	Conti et al.	257/761
	E	US-6,340,435	01-2002	Bjorkman et al.	216/72
	F	US-6,465,372	10-2002	Xia et al.	438/787
	G	US-6,399,489	06-2002	M'Saad et al.	438/680
	H	US-6,593,247	07-2003	Huang et al.	438/758
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.